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Application/Control	No.	•

Applicant(s)/P	atent	under
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10/004,589 Examiner

David Lazaro

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Class	Subclass	Date	Examiner
709	203-205, 218, 223- 226	8/15/2005	DRL
705	10, 14	8/15/2005	DRL

INI	NTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST: USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB Consulted: Susanna Diaz 3623	8/15/2005	DRL
NPL: ACM, Citeseer, IEEE, Google Focus: forum, board, review, rating, evaluation, usefulness, moderating, points	8/15/2005	DRL
PALM inventor search	8/15/2005	DRL
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